

MOSFET – Power, Dual

P-Channel

-40 V, -20 A, 12.5 m Ω

FDWS9520L-F085

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low QG and Capacitance to Minimize Driver Losses
- Wettable Flanks for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			VDSS	-40	V
Gate-to-Source Volta	ge		Vgs	±16	V
Continuous Drain		T _C = 25°C		-60.8	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C	I _D	-43.0	
Power Dissipation	State	T _C = 25°C		75	W
R _{θJC} (Note 1)		T _C = 100°C	P_{D}	37.5	
Continuous Drain		T _C = 25°C	I _D	-12.2	А
Current $R_{\theta JA}$ (Notes 1, 2, 3)	Steady State	T _C = 100°C		-8.6	
Power Dissipation R _{θJA} (Notes 1 & 2)		T _C = 25°C	P _D	3.0	W
		T _C = 100°C		1.5	
Pulsed Drain Current	T _C = 25°0	C, t _p = 10 μs	ldм	-281	Α
Operating Junction and Storage Temperature			TJ, Tstg	-55 to +175	°C
Source Current (Body Diode)			Is	-20	Α
Single Pulse Drain-to-Source Avalanche Energy (IL(pk) = -19)			Eas	90	mJ
Lead Temperature for Soldering Purposes (1/83 from case for 10 s)			T_L	260	°C

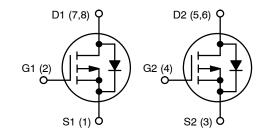
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	2	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	50	°C/W

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
-40 V	12.5 mΩ @ –10 V	-20 A
	19.5 mΩ @ -4.5 V	





ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 3 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
Off Characteristics	•				•	I.	•
Drain to Source Breakdown Voltage	V(BR)DSS	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V(BR)DSS/T _J				21		mV/°C
Zero Gate Voltage Drain Current	IDSS	V _{GS} = 0 V, V _{DS} = -40 V	T _J = 25°C			-1	μА
			T _J = 175°C			-1	mA
Zero Gate Voltage Drain Current	Igss	V _{DS} = 0 V, V _{GS} = ±16 V				±100	nA
On Characteristics (Note 4)	•						
Gate Threshold Voltage	Vgs(TH)	$V_{GS} = V_{DS}$, $I_D = -2$	250 μΑ	-1	-1.8	-3	٧
Threshold Temperature Coefficient	Vgs(TH)/TJ	,			-5.5		mV/°C
Drain-to-Source On Resistance	RDS(on)	V _{GS} = -10 V	I _D = -20 A		10.4	12.5	mΩ
		V _{GS} = -4.5 V	I _D = -10 A		14.6	19.5	1
Charges, Capacitances & Gate Resis	tance	1 . 43	.0 1071			. 5.5	
Input Capacitance	Ciss	V _{GS} = 0 V, f = 1 MHz, V _{DS} = -20 V			2370		pF
Output Capacitance	Coss				940		pF
Reverse Transfer Capacitance	Crss				40		pF
Gate Resistance	R _g	V _{GS} = 0.5 V, f = 1 MHz			17		Ω
Total Gate Charge	QG(TOT)	$V_{GS} = -10 \text{ V}, V_{DS} = -32 \text{ V}; I_D = -20 \text{ A}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -32 \text{ V}; I_D = -20 \text{ A}$			33		nC
					13		
Threshold Gate Charge	Qg(th)	V _{GS} = 0 to -1 V			2		
Gate to Source Gate Charge	Qgs	V _{DD} = -20 V _, I _D = -20 A			7		
Gate to Drain "Miller" Charge	Qgd				4		
Plateau Voltage	VGP				-4		V
Switching Characteristics						•	
Turn-On Delay Time	td(ON)	$V_{DD} = -20 \text{ V}, I_{D} = -20 \text{ A}, R_{GEN} = 6 \Omega$	V _{GS} = -10 V,		8		ns
Turn-On Rise Time	t _r	GEN 1011			21		ns
Turn-Off Delay Time	td(OFF)				120		ns
Turn-Off Fall Time	t _f				34		ns
Drain-Source Diode Characteristics	<u>'</u>	l		1		l	
Source to Drain Diode Voltage	VsD	I _{SD} = -20 A, V _{GS}	= 0 V		-0.9	-1.25	V
		I _{SD} = -10 A, V _{GS}			-0.83	-1.2	V
Reverse Recovery Time	TRR	$V_{GS} = 0 \text{ V}, \text{ dI}_{SD}/\text{dt} = 100 \text{ A/us}, \text{ I}_{S} = -20 \text{ A}$			46		ns
Charge Time	t _a		-		22		-
Discharge Time	t _b				24		1
Reverse Recovery Charge	QRR	1			37		nC
	<u> </u>	l .			<u> </u>	L	<u> </u>

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%

5. Switching characteristics are independent of operating junction temperatures.

ORDERING INFORMATION

Device	Device Marking	Package	Shipping [†]
FDWS9520L-F085	FDWS9520L	PQFN8 5x6, 12.7P (Pb-Free, Halogen Free)	3,000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D

TYPICAL CHARACTERISTICS

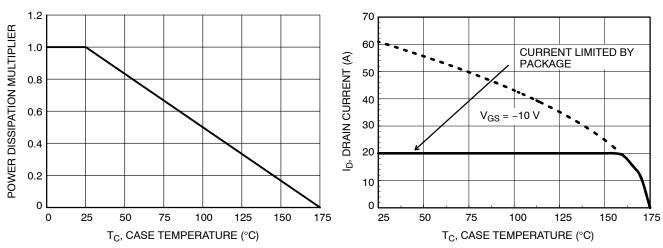


Figure 1. Normalized Power Dissipation vs.

Case Temperature

Figure 2. Maximum Continuous Drain Current vs. Case Temperature

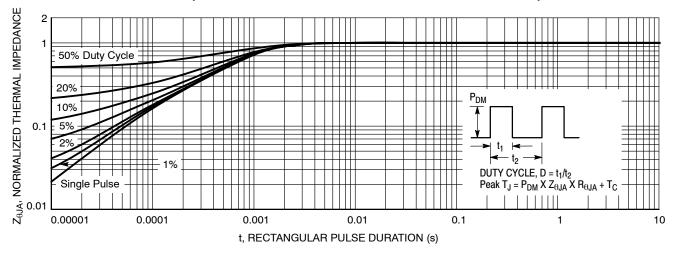


Figure 3. Normalized Maximum Transient Thermal Impedance

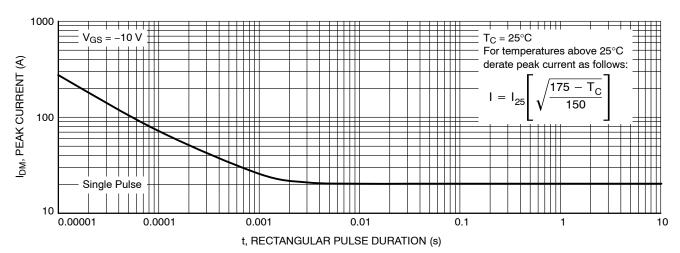


Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS

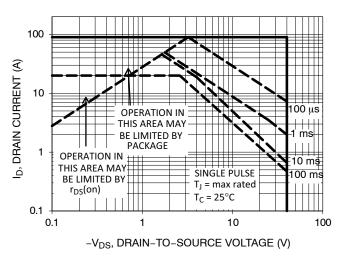


Figure 5. Forward Bias Safe Operating Area

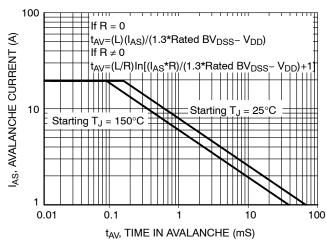


Figure 6. Unclamped Inductive Switching Capability

(Note: Refer to **onsemi** Applications Notes <u>AN7514</u> and <u>AN7515</u>)

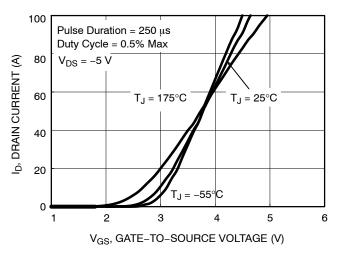


Figure 7. Transfer Characteristics

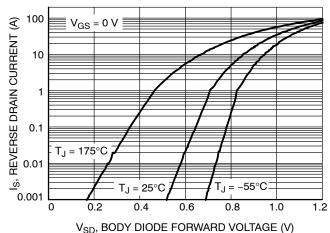


Figure 8. Forward Diode Characteristics

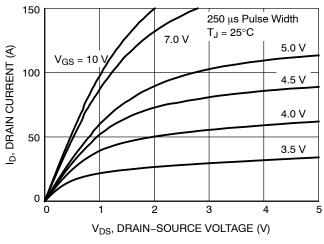


Figure 9. Saturation Characteristics

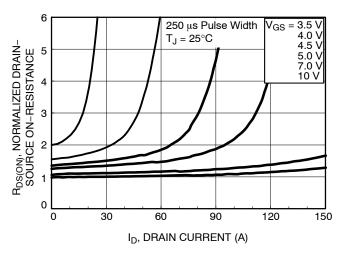
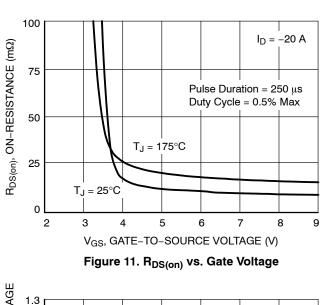


Figure 10. Normalized R_{DS(ON)} vs. Drain Current

TYPICAL CHARACTERISTICS



1.8

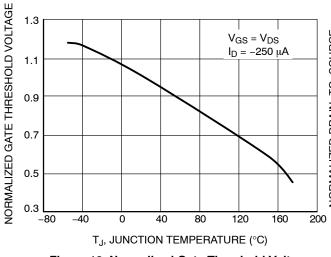
ID = -20 A

VGS = -10 V

ID = -20 A

VGS

Figure 12. Normalized R_{DS(on)} vs. Junction Temperature



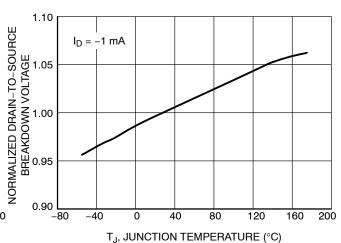
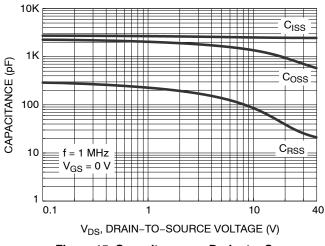


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

Figure 14. Normalized Drain-to-Source Breakdown Voltage vs. Junction Temperature



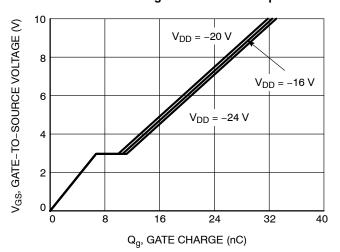
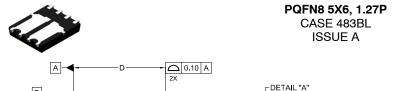


Figure 15. Capacitance vs. Drain-to-Source Voltage

Figure 16. Gate Charge vs. Gate-to-Source Voltage

MECHANICAL CASE OUTLINE



PKG

(4X)

(E5)

(2X)

E6 (4X)

(k1)

D2

BOTTOM VIEW

(E4) (2X)

-(D3)

b (8X)

E2 (2X)

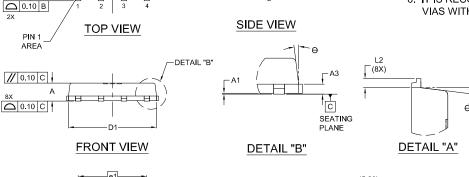
◆ 0.10**(M)** C A B 0.05**(M)** C

DATE 23 APR 2021

MILLIMETERS

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.



(5.20)
-1.78+ 2X -0.35
0.92
4.72 2X
3.80 2X AREA 6.91
0.77
1.42 4X
0.61 — — — — — — — — — — — — — — — — — — —
1.27 LAND PATTERN

DIM	MILLIMETERS			
	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
A1	0.00	-	0.05	
A3	0.23	0.28	0.33	
b	0.26	0.31	0.36	
b1	0.36	0.41	0.46	
D	5.00	5.10	5.20	
D1	4.80	4.90	5.00	
D2	1.51	1.61	1.71	
D3	0.54 REF			
E	6.20 6.30		6.40	
E1	5.70	5.80	5.90	
E2	3.58 3.68		3.78	
E3	0.30 REF			
E4	0.10 0.20 0.30			
E5	0.72 REF			
E6	0.59	0.69	0.79	
е	•	1.27 BSC	;	
e1	;	3.81 BSC	;	
e/2	0.635 BSC			
k	1.19 REF			
k1	0.60 REF			
k2	0.45 REF			
L	0.64	0.74	0.84	
L2	0.15	0.25	0.35	
Z	0.39 REF			
Θ	0°	-	7°	

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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